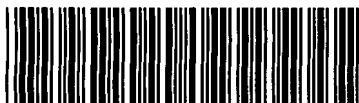


Search Notes**Application/Control No.**

10/552,811

Examiner

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**Applicant(s)/Patent under
Reexamination**

BAIER ET AL.

Art Unit

2879

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Class	Subclass	Date	Examiner
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**SEARCH NOTES
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	DATE	EXMR
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